

Key Features

Type CBT Series

Solid Carbon Composition

Designed for Pulse Withstand

Low Cost, High Performance

Two Sizes Available

Supplied Ammo Pack in boxes of 2000

NOTE:

5% Tolerance Version Discontinued From 31/12/2022



The CBT series of resistors is constructed utilising solid carbon composition, which is the traditional medium for absorbing high energy pulses, in cases of high inrush current. These resistors have evolved over many years to have excellent pulse withstand capabilities, whilst remaining very stable. These improved characteristics have been achieved by prudent selection of materials of optimum physical properties and by advances in the manufacturing process.

Characteristics – Electrical

	CBT25			CBT50			
Power @ 70°C	0.25W (~0 @ 125°C)		0.5W (~	0.5W (~0 @ 125°C)			
Maximum Voltage		250V			350V		
Tolerance	10%	10%	20%	10%	10%	20%	
Selection Series	E24	E12	E6	E24	E12	E6	
Resistance values Ω	100K – 5M6 1R – 5M6		100K – 22M	- 1R – 22M			
Limiting Element Voltage	250v			350v			
Maximum Overload Voltage	500v			700v			
Insulation Resistance	1000M minimum						
Insulation Voltage	100v			500v			
Dielectric Strength	142v		710v				
Operating Temperature	-55 ~ +125						

Climatic Category

55/125/56	Lower Category Temperature Upper Category Temperature Damp Heat Steady State Duration	-55°C +125°C 56 Days	
Stability Class			
10%	Limits For Change of Resistance		
	For Long Term Tests	±(10%+0.5Ω)	
	For Short Term Tests	±(2%+0.1Ω)	
.			

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Dimensions in millimetres unless otherwise specified Dimensions Shown for reference purposes only. Specifications subject to change



Derating

At ambient temperatures in excess of 70°C the resistor shall be derated in accordance with the following curve:



Rated Voltage

D.C. or A.C. rms voltage calculated from the square root of the product of the rated resistance and the rated dissipation.



Where the calculated rated voltage is higher than the limiting element voltage, the limiting element voltage must be applied.

Dimensions



	L	ØD		Ød
CBT25	6.3±0.7	2.4±0.1	30±3	0.6±0.05
CBT50	9.5 ^{+0.8} -0.7	3.6±0.2	25±3	0.7 ^{+0.07} -0.05

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Performance Characteristics

		Performance
Test Item	Condition of Test (JIS C 5201-1)	Requirement
Visual Examination	Sub-clause 4.4.1 Checked by visual examination	As per 4.4.1 Marking shall be legible as checked visually
Dimension	Sub-clause 4.4.2	As specified
Resistance	Sub-clause 4.5	As specified Resistance value shall correspond to the rated resistance value taking into account the specified tolerance
Voltage Proof	Sub-clause 4.7 Method: V-Block Method Test Voltage: Alternating voltage with a peak value of 1.42 times the insulation voltage. Duration 60s ±5s	No breakdown or flashover
Solderability	Sub-clause 4.17 Without ageing Method 1 (solder bath method) Bath Temperature: 235°C±5°C Immersion time: 5s ±0.5s Immersion depth: A point within about 4mm from the resistor body.	Good tinning as evidenced by free flowing of the solder with wetting of the terminations
Overload (mounted)	Sub-clause 4.13 The applied voltage shall be 2.5 times RCWV or 2 times limiting element voltage, whichever is lower. Duration: 5s Visual Examination Resistance test	No Visible Damage Legible Marking ΔR≤±(2%+0.1Ω)
Terminal strength Tensile	Sub-clause 4.16 Sub-clause 4.16.2 Force: 10N Duration: 10s ±1s	
Bending	Sub-clause 4.16.3 Method 1 Bending times: 2 times Bending force: 5N	No visible damage ΔR≤±(2%+0.1Ω
Torsion	Sub-clause 4.16.4 Method A, Severity 2 (2 successive rotations of 180°)	

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	Sub-clause 4.18			
	Method 1B			
	Solder Temperature:	No Visible Damage		
Resistance to soldering heat	CBT25: 300°C±10°C	Legible marking		
	CBT50: 350°C±10°C			
	Immersion time: 3.5s±0.5s	ΔR≤±(3%+0.1Ω		
	Immersion depth: A point within			
	4.0 ± 0.8 mm from the resistor body.			
	Sub-clause 4.19			
	Lower category temperature: -			
	55°C			
Rapid Temperature	Upper category temperature:	No visible damage		
change	125°C	ΔR≤±(2%+0.1Ω		
	Duration of exposure at each			
	temperature: 30 min.			
	Number of cycles: 5			
	Sub-Clause 4.22			
	Endurance by sweeping			
	Frequency range: 10Hz – 500Hz			
Vibration		No visible damage		
VIUIATION	Amplitude: 0.75mm or	ΔR≤±(2%+0.1Ω		
	acceleration 98m/s ²			
	(whichever is less severe)			
	Total Duration: 6h			
Climatic sequence	Sub-clause 4.23			
	Sub-clause 4.23.2			
Dry Heat	Test temperature: 125°C			
	Duration 16h			
	Sub-clause 4.23.3			
Damp Heat, cycle	Test Method: 2			
(12 + 12h cycle	Test temperature: 55°C			
First Cycle	(Severity (2))			
	Sub-clause 4.23.4			
Cold		No Visible Damage		
Colu	Test temperature: -55°C	Legible marking		
	Duration: 2h	ΔR≤±(10%+0.5Ω)		
Low air pressure	8kPa	· · · ·		
	Sub-clause 4.23.6	Insulation Resistance:		
Damp heat, cycle	Test method: 2	R≥100 MΩ		
(12 + 12h cycle)	Test temperature: 55°C	115 TOO 14175		
Remaining cycle	(Severity (2))			
<i>. .</i>	Number of cycles: 5			
	Sub-clause 4.23.7			
	The applied voltage shall be the			
	rated voltage or the limiting			
D.C. load				
	element voltage, whichever is			
	smaller.			
	Duration: 1 min.			
	Sub-clause 4.25.1			
	Ambient temperature: 70°C±2°C			
	Duration: 1000h			
	Voltage applied 1.5h on and 0.5h	No visible damage		
	off	ΔR≤±(10%+0.5Ω)		
Endurance @ 70°C	The applied voltage shall be the			
	rated voltage or the limiting	Insulation Resistance:		
	element voltage, whichever is	R≥1 GΩ		
	smaller			
	Examination at 48h, 500h and			
	1000h			

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		At -	55°C
		Resistance	Temp.
		Range	Coefficient
		R≤1KΩ	+6.5-0(%)
		R≤10KΩ	+10-0(%)
		R≤100KΩ	+13-0(%)
Maniatian af	Cub shares 4.0	R≤1MΩ	+15-0(%)
Variation of	Sub-clause 4.8	R>1MΩ	+20-0%
Resistance with	-55°C / +20°C +20°C / +125°C	At +1	25°C
Temperature	+20 C7 +125 C	Resistance	Temp.
		Range	Coefficient
		R≤1KΩ	+1-5(%)
		R≤10KΩ	0-6(%)
		R≤100KΩ	0-7.5(%)
		R≤1MΩ	0-10(%)
		R>1MΩ	0-15(%)
Damp Heat, Steady State	Sub-clause 4.24 Ambient Temperature: 40°C±2°C Relative Humidity: 93*2/-3% a) 1 st group: without voltage applied b) 2 nd group: DC voltage applied continuously in accordance with sub- clause 4.24.2.1b c) 3 rd group: DC voltage – 20v±2v shall be applied continuously.	Legible ∆R≤±(10 Insulation	e Damage marking ۱%+0.5Ω) resistance ΟΜΩ
Endurance at upper category temperature	Sub-clause 4.25.3 Ambient temperature: 125°C±2°C Duration: 1000h Examination at 48h, 500h and 1000h Visual examination Resistance At 1000h only: Insulation Resistance	∆R≤±(10	e Damage 1%+0.5Ω) sistance ≥1GΩ

Packaging

Taping in accordance with JIS C 0806-1:1999



	\	V	Р	L1 - L2	Z	S	Т	t
CBT25	52.4	+1.6	5.08±0.38	1.0 max	1.0 max	3.2 min	6.0±0.5	0.5 max
CBT50	52.4	-1.4	5.08±0.58	1.0 max	1.0 1118	5.2 11111	0.0±0.5	0.5 11188

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Packaging

Notes:

The direction of the color codes should be unified.

No component shall be missed.

Wire leads shall be free from kinks and bends.

Pitch tolerance is 2mm for 20 pitches (100±2mm).

The edge waving on tape shall not be more than ± 1.0 mm through a length of 300mm.

The reinforcement of the tape cutting should be reinforced by a new tape (30mm min) in 3mm limits and ensuring 1 pitch dimension as shown below.



Tape in Box (Ammo Pack)



	Code	Qty per Box	а	b	С
CBT25	No Code	2000	60±5	75±5	275±5
CBT50	No Code	2000	65±5	75±5	455±5

How To Order

CBT	25	J	10K
Common Part	Size	Tolerance	Resistance Value
			1Ω - 1R0
CBT – Carbon	25 – 0.25W	J — 5%	100Ω - 100R
Composition	23 – 0.23W 50 – 0.5W	K – 10%	1000Ω (1ΚΩ) - 1ΚΟ
Resistor	50-0.500	M – 20%	100000Ω (100ΚΩ) - 100Κ
			1000000Ω (1ΜΩ) - 1Μ0

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